

# Analysis of Booster and Storage Ring RF System Reliability at the Advanced Photon Source

Doug Horan – Advanced Photon Source RF Group 2010 – Sixth CW and High Average Power RF Workshop ALBA, Barcelona, Spain



#### 2008 APS Reliability Statistics By System

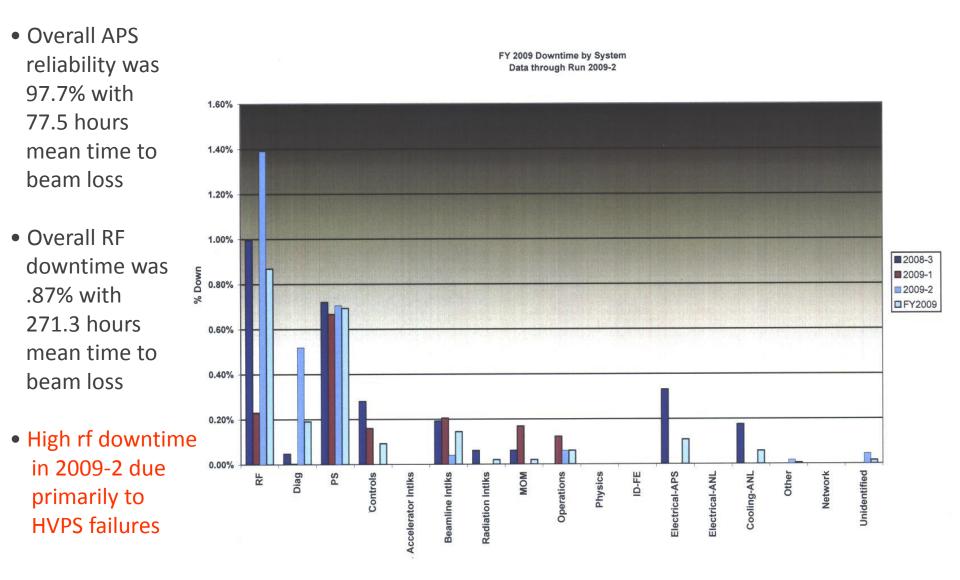
 Overall APS reliability 3.00% was 97.6% with 2007-3 91.4 hours mean 2008-1 2008-2 2.50% time to beam loss FY2008 Overall RF downtime 2.00% was 1.04% with 319.9 hours mean % Down 1.50% time to beam loss 1.00% 2.75% rf downtime in 2008 was due to booster coupler 0.50% Unidentified П 0.00% Other Diag Cooling-ANL Network Controls Beamline Intlks Radiation Intlks MOM ID-FE R PS Accelerator Intlks Operations Physics Electrical-APS Electrical-ANL

FY 2008 Downtime by System Data through Run 2008-2

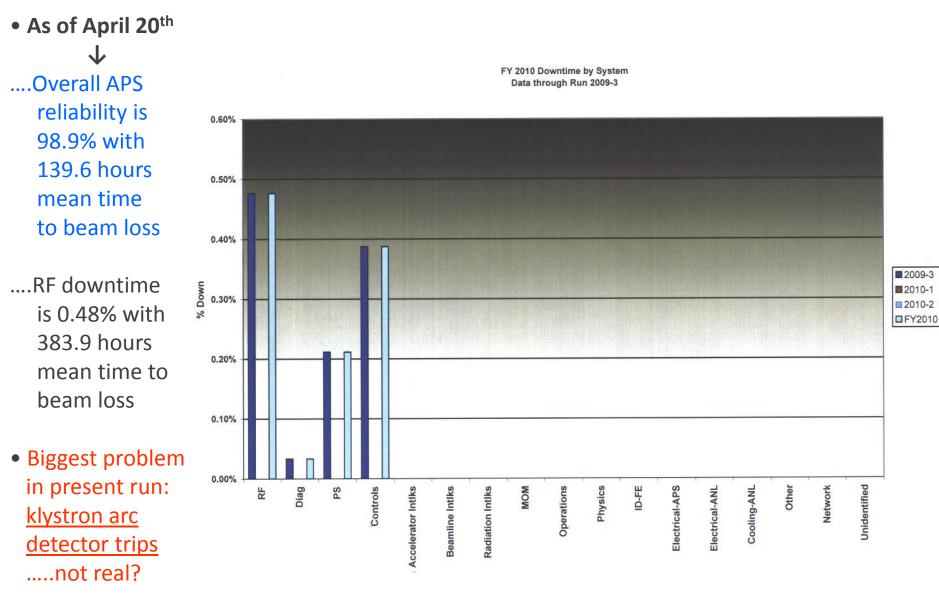
failure

Updated 8/18/8

#### 2009 APS Reliability Statistics By System

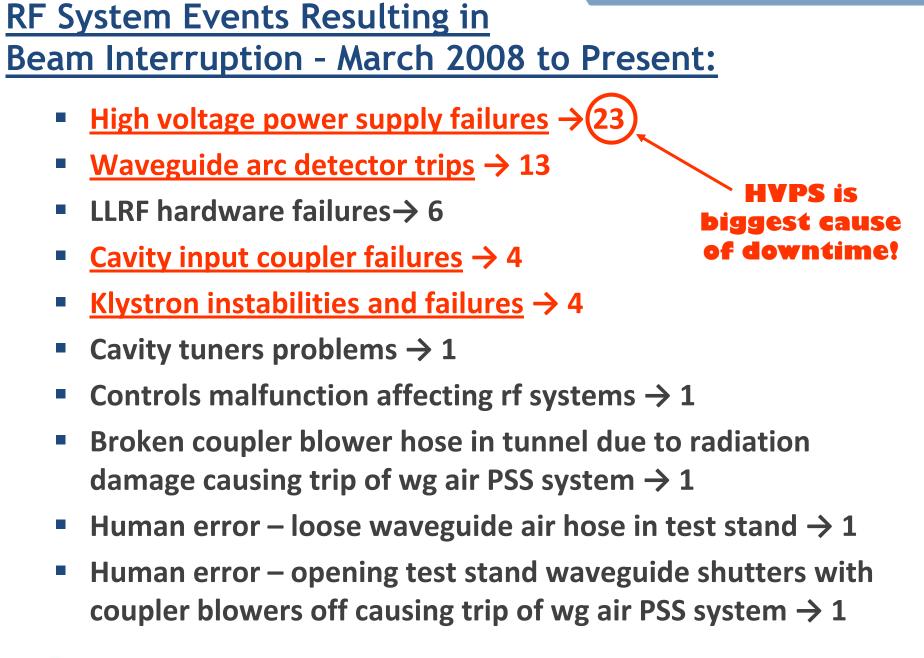


#### 2010 APS Reliability Statistics By System



Doug Horan -- APS Booster and Storage Ring RF System Reliability -- 2010 CWRF Workshop May 4-7, 2010

4



#### **RF System High-Voltage Power Supplies**

- Installed new in 1992-94.....approximately 90,000 average operating hours per system since 1995
- Conventional design, 95kV@20A maximum output:
  - → Transformer-Rectifier
  - $\rightarrow$  SCR voltage control
  - → Ignitron crowbar
  - → Tetrode mod-anode modulator

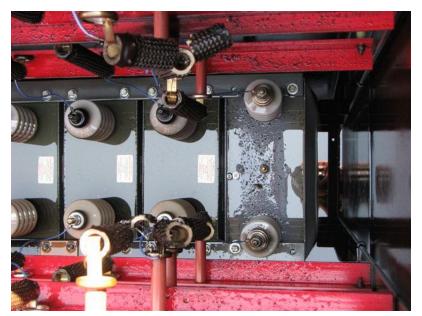
→ Most frequent cause of downtime in the last two years

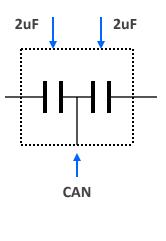
#### **HVPS Sub-System Problem Areas**

- Transformer-rectifier set capacitor bank
- Mod-anode regulator
- Pantak cable connectors and sockets
- Control system
- Cathode voltage regulator (SCR's)
- 13.2kV Fused Disconnect Switch

# Transformer-Rectifier Set Capacitor Failures

- T-R set capacitor bank consists of eight 2x2uF capacitors arranged in series/parallel:
  - $\rightarrow$  Ct = 8uF at 95kV max
- Routine inspection of the RF5 T-R set in May 2008 revealed several failed capacitors – *predicted lifetime was* <u>20 years</u>
- Original capacitors were obsolete and out of production by manufacturer
- Replacement capacitors were secondsourced to another manufacturer, <u>hipot tested twice</u>, and installed in the RF4 T-R set in May of 2009







#### Transformer-Rectifier Set Capacitor Failures

- Most of the new caps failed after approximately one week service!
- The cause of the failures was determined to be incomplete oil impregnation to all sections of the capacitor:





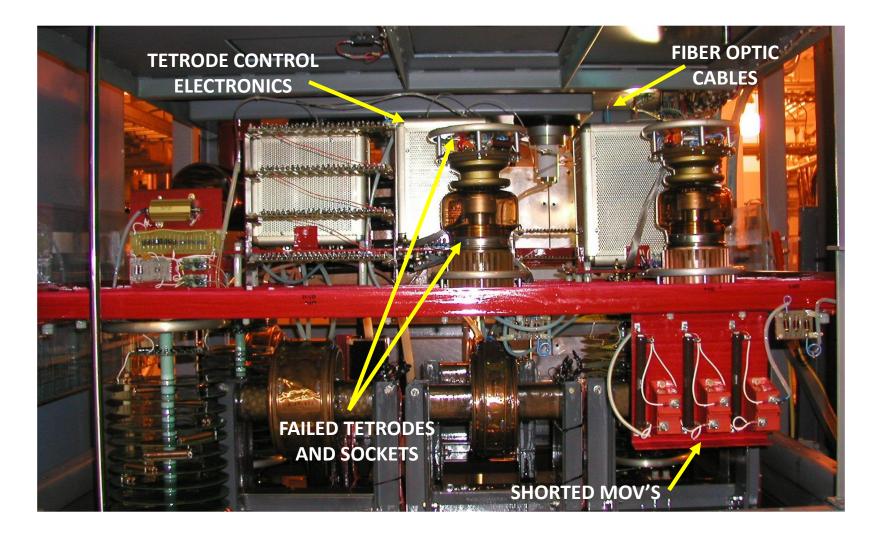


# Transformer-Rectifier Set Capacitor Failures

- The original caps were re-installed in the RF4 T-R set so operation could resume
- A search for a second vendor was started
- New caps were ordered from Vendor #2 and were installed in RF4 during the August 20090 maintenance shutdown
- No further problems with caps from vendor #2
- Lessons learned:
  - → "old-school" high-voltage components may not be so easy to get nowadays
  - → try to secure two vendors for such parts, and maintain adequate spares

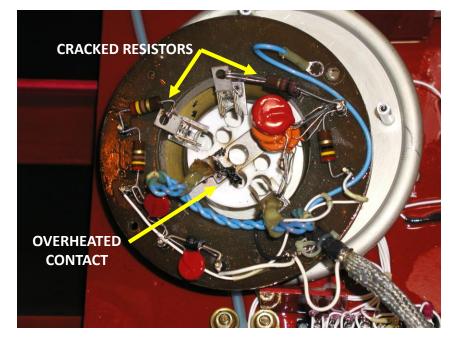
#### **Mod-Anode Regulator Failures**

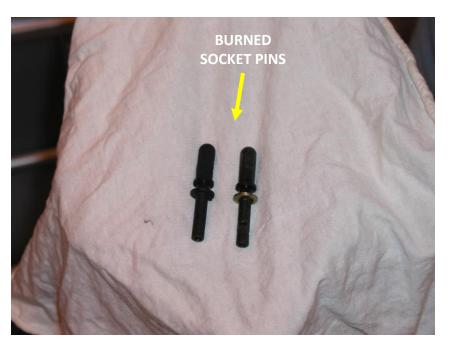
Many component failures resulting in significant downtime:



#### Mod-Anode Tetrode Socket Failures

- Over-heating of center pin tetrode contact due to trapped oil, causing intermittent loss of heater power
- 2-watt carbon composition resistors cracking
  - → temperature?.....old age?

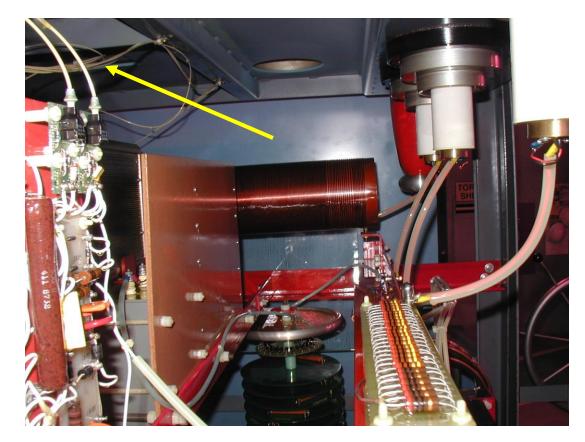




# Solution: Drill oil escape hole in center of socket cover, and replace all carbon composition resistors with 3-watt metal film

#### Mod-Anode Fiber Optic Cables

 X-rays from tetrodes degrade fast glass fiber optic cables, impeding analog communication with tetrode control electronics cages and resulting in loss of anode regulation



**Solution:** Convert to radiation-resistant plastic fiber cables with larger active area

#### **Tetrode Failures**

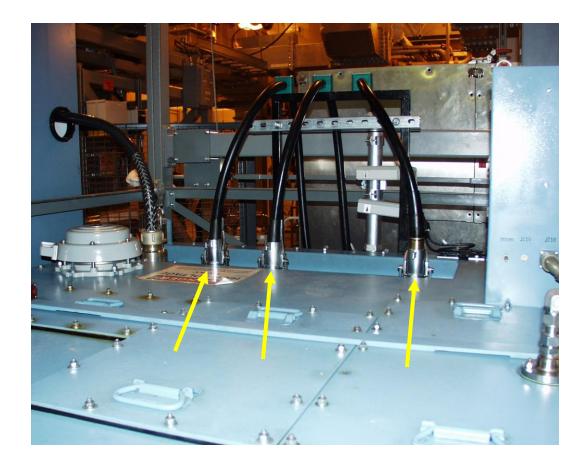
- Two Thales TH5188 tetrodes are used as an active voltage divider in modanode regulator
- Production of TH5188 ceased approximately five years ago – we made bulk purchase for spares
- Approximately 5 verified failures in the last ten years



<u>Solution</u>: A tetrode test set was constructed to evaluate and test new and used tetrodes and other mod-anode electronics modules under high-voltage operation conditions

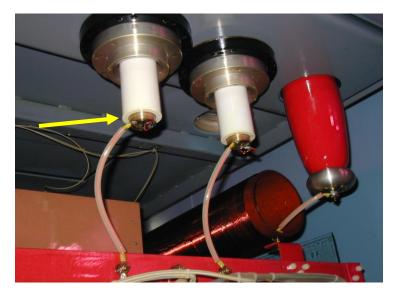
#### Problems with Pantak Cable Connections Between HVPS and Klystron

- Numerous HVPS system failures have occurred due to:
  - → cable failures due to high voltage breakdown
  - → Intermittent socket connections



#### Improved Pantak Socket Tip Connector

- Original tri-axial tip connector was sensitive to insertion force and would result in intermittent filament contact
- Solution: Re-designed one-piece tip contact with fingerstock provided positive contact to tip and ring bushings on





plug

**TESTED AT 50A!** 





#### Pantak Cable High Voltage Failures

 Suspect causes include defects in connector or plug molding, potting, or material, incorrect plug insertion force, insufficient grease, undetected HV damage to the mating socket



# Solution: Increased awareness of proper insertion force, improved technician training on Pantak connector inspection and maintenance

#### Failures in HVPS Control System

- Original control system, circa 1990:
  - → many obsolete parts
  - → PC computer interface program written in Windows 3.1, running on Windows 95 OS!
  - → many intermittents on board connectors

Solution: Replace entire control system with a modern PLC......project currently underway



#### Cathode Voltage Regulator -SCR Cabinet Failures



2007 EVENT

**1996 EVENT** 





- Three catastrophic events have occurred: 1996, 2003, 2007
- Root cause in 1996 and 2007 events was traced to failure of SCR snubber capacitors

**Solution:** Replace original capacitors, and re-configure wiring between SCR stacks to reduce possibility of phase-to-phase shorts when components fail

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FAILED SNUBBER CA

# **13.2kV Fused-Disconnect Switches**

- Original switches *notoriously* unreliable
  - $\rightarrow$  Failure rate as high as once every 10 operations!
  - $\rightarrow$  Would stick in both open and closed positions!
  - $\rightarrow$  Switch was obsolete at time of installation....1992!
- Replaced by new switch that is more robust and easier to maintain, with improved personnel safety features







#### Waveguide Arc Detector Trips

- Typically occur once every 2 months per rf system, roughly 5-6 total per year......are they real or false?
- Typical causes when arcs are considered real:
  - → Humid air from storage ring tunnel blown into waveguides by coupler blowers -- common when weather is wet, rainy...... tunnel air is not controlled for humidity or temperature
  - → Arcing between ferrites in circulators coming out of a shutdown......dust settling on ferrites?
- Typical causes when arcs are considered false:
  - → Radiated electrical noise coupling into arc detector electronics
- Number of arc detector trips since January 2010 is very high....7 total!
  - → Radiated noise suspected.....arc detector trips occurred on klystrons that were in standby diode mode!

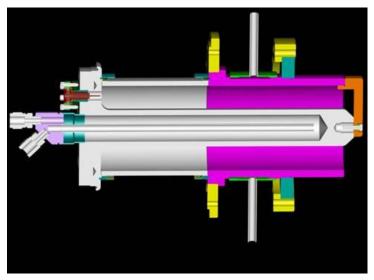
#### <u>Solution</u>: Find noise source.....*investigation ongoing!*

#### **Cavity Input Coupler Failures**

- Four coupler failures in the last two years:
  → 3/22/08 Booster C1 -- sudden pinhole leak in ceramic
  - → 4/25/08 S40/C2 intermittent vacuum trips
  - → 6/04/08 S40/C2 new coupler destroyed by overpower accident during beam studies
  - → 6/17/09 S40/C2 sudden pinhole leak in ceramic
- Operating data before failure and postmortem analysis did not find a definite cause for ceramic pinhole leaks



FAILED BOOSTER C1 COUPLER



STORAGE RING COUPLER DESIGN

# **Klystron Trips and Instabilities**

• Only two *verified* klystron-related beam losses in the last two years:

→ klystron vacuum trip (1)

→ sideband instability (1)

.....a relatively low number considering the accumulated operating hours:

RF1 → EEV s/n 01 = 73,409 hr

**RF2** → Thales s/n 089041 = 56,231 hr

RF3 → EEV s/n 089041 = 57,548 hr

RF4 → Thales s/n 089030 = 29,757 hr

RF5 → Thales s/n 089026 = 48,073 hr

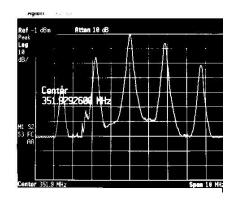


**EEV K3513A** → most reliable, free of instabilities

<u>Thales TH2089A</u>  $\rightarrow$  reliable, but can become unstable at certain operating points

#### **Klystron Instabilities**

 The common sideband instability seen in the TH2089A results in very strong sidebands spaced ~ 2MHz from the carrier:



- Typical remedies:
  - → change cathode voltage by 1-3kV
  - → adjust circulator bias to increase reflected power in the direction of <u>slightly lower efficiency</u>
- In most cases sidebands can be suppressed



Klystron sidebands can occur without warning and typically result in beam loss during a fill

### **Recent Failure of a Klystron**

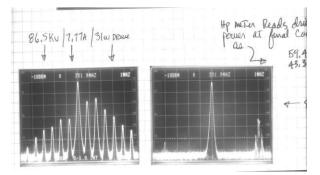
- TH2089A, s/n 089043, failed after approximately 1,850 hours of operation
- Purchased new in 2001, sat in storage for eight years
- Was installed at RF2 in January of 2010 and ran normally in storage ring service for approximately three months
- On April 6<sup>th</sup> it suddenly developed severe sideband instability that could not be corrected by normal means
- Preliminary investigation indicates severe dc leakage across modanode/cathode ceramic (~ 2.5mA at 60kV)
- No crowbar or HV breakdown events were logged



Investigation is ongoing.....

#### **Klystron Instabilities**

 Suspected multipactor losses in klystron C1 and/or C2 can result in sudden loss of efficiency and erratic rf power output, and have produced 800kHz sidebands:



- Typical remedy:
  - → Adjust rf drive power to avoid multipactor region -- <u>penalty</u>: loss of efficiency
- In most cases the instability can be avoided without excessive loss of efficiency



C1/C2 multipactor can severely limit useful operating parameter range

#### Upgrade of Legacy RF System Hardware to Improve Reliability

Replacement of original process meter-relay logic interlock systems with modern PLC hardware:



ORIGINAL SYSTEM WITH INDIVIDUAL PROCESS METERS



NEW PLC INTERLOCK SYSTEM INSTALLATION

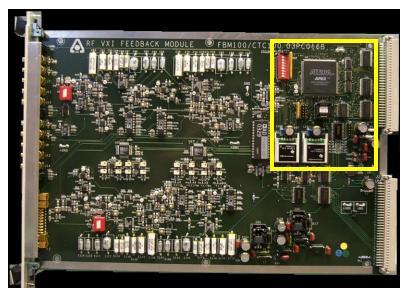
#### Upgrade of Legacy RF System Hardware to Improve Reliability

 Upgrade of original low-level rf boards (circa 1990) with new data acquisition hardware:





#### LLRF BOARD WITH ORIGINAL DATA ACQUISTION HARDWARE



NEW LLRF BOARD WITH UPDATED ACQUISTION HARDWARE

# Ongoing Effort to Maintain and Improve RF System Reliability

- Maintain adequate spares and avoid reliance on obsolete hardware wherever possible
- Implement design improvements on input couplers
  Work underway; see D. Bromberek talk
- Increased attention paid to HVPS systems
- Investigate <u>every</u> fault to determine the root cause......
  <u>then implement change to prevent a future occurrence</u>

#### THE PLACE IS GETTING OLD!.....THE FIGHT NEVER ENDS!